Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/564,427	BICK ET AL.
Examiner	Art Unit
WEIPING ZHU	1734

	SEARCHED			
Class	Subclass	Date	Examiner	
B22F	\$	7/19/2011	WZ	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH I (INCLUDING SEAR)
	DATE	EXMR
Updated EAST Search	7/19/2011	WZ